


<b>Search Notes</b>  	<b>Application/Control No.</b>  10568291	<b>Applicant(s)/Patent Under Reexamination</b>  KAIHOKO ET AL.
	<b>Examiner</b>  DAQUAN ZHAO	<b>Art Unit</b>  2621

SEARCHED			
Class	Subclass	Date	Examiner
386	68, 95, 125-126	12/30/2009	dz

SEARCH NOTES		
Search Notes	Date	Examiner
USPAT; USPGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB	12/30/2009	DZ
consult with Thai Tran for 101 of method claims and medium claim	12/30/2009	dz

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

--	--